

Issue Classification

Application/Control No.

10801894

Applicant(s)/Patent Under Reexamination

JIAO ET AL.

Examiner

Nguyen, Khiem D

Art Unit

2823

ORIGINAL**INTERNATIONAL CLASSIFICATION**

CLASS

SUBCLASS

CLAIMED

NON-CLAIMED

438

118

H O I L

21 / 00 (2006.01.01)

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

438

455

Nguyen, Khiem D *Khiem Nguyen*
(Assistant Examiner) (Date) 6/10/07

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Total Claims Allowed:

12

Shana Steptoe 7/11/07
(Legal Instruments Examiner) (Date)

Michael Smith 7/18/07
(Primary Examiner) (Date)

O.G. Print Claim(s)

1

O.G. Print Figure

5